**Product data sheet** 

## 1. General description

Silicon Carbide MOSFET in a TO263-7L plastic package, featured with easy-drive characters, designed for compact and robust systems.



## 2. Features and benefits

- · Kelvin source configured
- Low specific on-resistance
- Optimized for low driving voltage
- 0V turn-off VGS for simple gate driving
- Robust gate design
- Optimized dynamic performance
- 100% UIS Tested
- Easy to parallel
- RoHS compliant

## 3. Applications

- Switch mode power supplies
- UPS & Energy storage system
- Motor Drives

### 4. Quick reference data

#### Table 1. Quick reference data

able I. Qu	iick reference data						
Symbol	Parameter	Conditions	Notes	Values			Unit
Absolute	maximum rating						
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C			1700		V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>mb</sub> = 25 °C			17		Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C, T <sub>j</sub> = 175 °C			153		W
T <sub>j</sub>	junction temperature			-55 to 175		°C	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	aracteristics						
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = 15 \text{ V}; I_D = 2 \text{ A}; T_j = 25 ^{\circ}\text{C}$		-	360	-	mΩ
		V <sub>GS</sub> = 18 V; I <sub>D</sub> = 2 A; T <sub>j</sub> = 25 °C		-	295	560	mΩ
Dynamic	characteristics						
Q <sub>G(tot)</sub>	total gate charge	$I_D = 2 \text{ A}; V_{DS} = 1200 \text{ V}; V_{GS} = 0 \text{ V}/18 \text{ V};$		-	21.1	-	nC
$Q_{GD}$	gate-drain charge	T <sub>j</sub> = 25 °C		-	7.0	-	nC
Source-d	rain diode		1	1			
$Q_r$	recovered charge	$I_{SD}$ = 2 A; $V_{GS}$ = 0 V/15 V; di/dt = 640 A/ $\mu$ s; $R_G$ = 2.4 $\Omega$ ; $V_{DS}$ = 800 V; $T_j$ = 25 °C		-	20	-	nC

# 5. Pinning information

#### **Table 2. Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	SS	source sense		
3-7	S	source		G
mb	D	mounting base; connected to drain	TO263-7L	SS Sym301 S

# 6. Ordering information

### **Table 3. Ordering information**

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WNSC2M360170B7	TO263-7L	WNSC2M360170B76J	Reel	800	TO263P-7L	05-Mar-2024

## 7. Marking

### **Table 4. Marking codes**

Type number	Marking codes
WNSC2M360170B7	WNSC2M 360170B7

# 8. Limiting values

### **Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		1700	V
$V_{\rm GS,max}$	gate-source voltage	Absolute maximum values		-12 to 24	V
$V_{GS,op}$	gate-source voltage	Recommended operational values		0 to 15	V
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C, T <sub>j</sub> = 175 °C		153	W
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>mb</sub> = 25 °C		17	Α
		V <sub>GS</sub> = 18 V; T <sub>mb</sub> = 100 °C		12	А
I <sub>DM</sub>	peak drain current	pulse width t <sub>p</sub> limited by T <sub>jmax</sub>	Fig.17	34	Α
Is	continuous diode current	V <sub>GS</sub> = 0 V; T <sub>mb</sub> = 25 °C		20	А
I <sub>SM</sub>	pulse diode current	$V_{GS}$ = -4 V; pulse width $t_p$ limited by $T_{jmax}$		34	А
E <sub>as</sub>	single pulse drain-to- source avalanche	$I_{AS} = 9 \text{ A}; L = 1 \text{ mH}; V_{DD} = 100 \text{ V};$ $T_j = 25 \text{ °C}$		40.5	mJ
T <sub>stg</sub>	storage temperature			-55 to 175	°C
T <sub>j</sub>	junction temperature			-55 to 175	°C
$T_{sld(M)}$	peak soldering temperature			260	°C

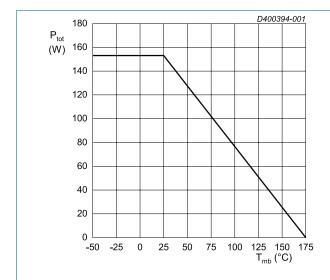


Fig. 1. Total power dissipation as a function of mounting base temperature; maximum values

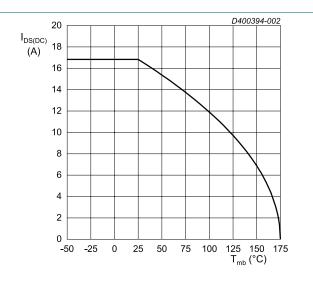


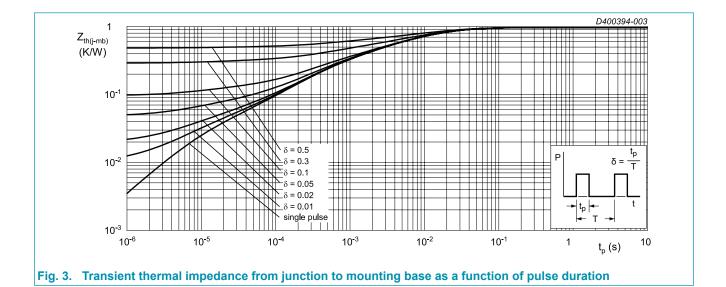
Fig. 2. Continuous Drain Current as a function of mounting base temperature

## 9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base			-	0.98	-	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W

Note: Device is ESD sensitive. Handling precautions are recommended.



## 10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 100 \mu A; V_{GS} = 0 V; T_j = 25 °C$		1700	-	-	V
$V_{\text{GS(th)}}$	gate-source threshold	$I_D = 2 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C}$		2.1	3.1	4.3	V
voltage	voltage	$I_D = 2 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 175 ^{\circ}\text{C}$		-	2.3	-	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 1700 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	0.1	100	μA
		V <sub>DS</sub> = 1700 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 175 °C		-	1	-	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 24 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$		-	1	100	nA
		V <sub>GS</sub> = -12 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C		-	1	100	nA
R <sub>DS(on)</sub>	drain-source on-state	V <sub>GS</sub> = 12 V; I <sub>D</sub> = 2 A; T <sub>j</sub> = 25 °C		-	550	-	mΩ
	resistance	$V_{GS} = 15 \text{ V}; I_D = 2 \text{ A}; T_j = 25 ^{\circ}\text{C}$		-	360	-	mΩ
		$V_{GS} = 18 \text{ V}; I_D = 2 \text{ A}; T_j = 25 \text{ °C}$		-	295	560	mΩ
		$V_{GS} = 18 \text{ V}; I_D = 2 \text{ A}; T_j = 175 \text{ °C}$		-	540	-	mΩ
$R_{\text{G}}$	gate resistance	f = 1 MHz; T <sub>j</sub> = 25 °C		-	3.5	-	Ω
g <sub>fs</sub>	transconductance	$V_{DS} = 20 \text{ V}; I_D = 2 \text{ A}; T_j = 25 \text{ °C}$		-	1.4	-	S
Dynamic	characteristics		,	•			
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 2 A; V <sub>DS</sub> = 1200 V; V <sub>GS</sub> = 0 V/18 V;		-	21.1	-	nC
Q <sub>GS</sub>	gate-source charge	T <sub>j</sub> = 25 °C		-	5.2	-	nC
$Q_{GD}$	gate-drain charge			-	7.0	-	nC
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 1000 V; V <sub>GS</sub> = 0 V; f = 1 MHz;		-	445	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C		-	20	-	pF
C <sub>rss</sub>	reverse transfer capacitance			-	2.78	-	pF
E <sub>oss</sub>	Coss stored energy			-	10	-	μJ
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 800 \text{ V}; V_{GS} = 0 \text{ V}/15 \text{ V}; R_{G(ext)} = 2.4$		-	19	-	ns
t <sub>r</sub>	rise time	$\Omega$ ; $I_D = 2 A$ ; $L = 330 \mu H$ ; $T_j = 25 °C$		-	23	-	ns
$t_{d(off)}$	turn-off delay time			-	36	-	ns
t <sub>f</sub>	fall time			-	28	-	ns
E <sub>on</sub>	turn-on energy (Body Diode FWD)			-	82	-	μJ
E <sub>off</sub>	turn-off energy (Body Diode FWD)			-	17	-	μJ
Source-d	rain diode		J.		1	1	
V <sub>SD</sub>	source-drain voltage	V <sub>GS</sub> = 0 V; I <sub>SD</sub> = 1 A; T <sub>j</sub> = 25 °C		-	2.6	-	V
		V <sub>GS</sub> = 0 V; I <sub>SD</sub> = 1 A; T <sub>j</sub> = 175 °C		-	2.4	-	V
		$V_{GS} = -4 \text{ V}; I_{SD} = 1 \text{ A}; T_j = 25 \text{ °C}$		-	3.8	-	V
		$V_{GS} = -4 \text{ V}; I_{SD} = 1 \text{ A}; T_j = 175 \text{ °C}$		-	3.2	-	V
t <sub>rr</sub>	reverse recovery time	$I_{SD}$ = 2 A; $V_{GS}$ = 0 V/15 V; di/dt = 640 A/ $\mu$ s; $R_{G}$ = 2.4 $\Omega$ ; $V_{DS}$ = 800 V; $T_{i}$ = 25 °C		-	7	-	ns
Q <sub>r</sub>	recovered charge	Mo, 11G - 2.7 12, V <sub>DS</sub> - 000 V, 1j - 23 O		-	20	-	nC
I <sub>rrm</sub>	reverse recovery current			-	5	-	Α

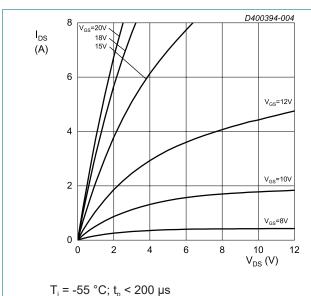
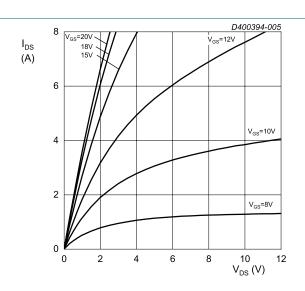
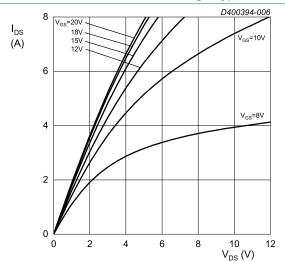


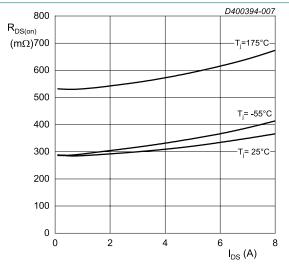
Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



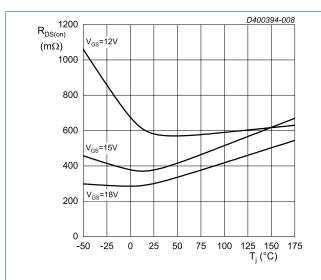
T<sub>j</sub> = 25 °C; t<sub>p</sub> < 200 μs Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



T<sub>j</sub> = 175 °C; t<sub>p</sub> < 200 μs Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

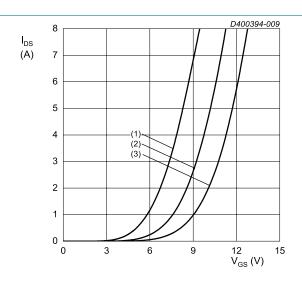


 $V_{GS}$  = 18 V;  $t_p$  < 200 µs Fig. 7. Drain-source on-state resistance as a function of drain current; typical values



 $I_{DS}$  = 2 A;  $t_p$  < 200  $\mu s$ 

Fig. 8. Drain-source on-state resistance as a function of junction temperature



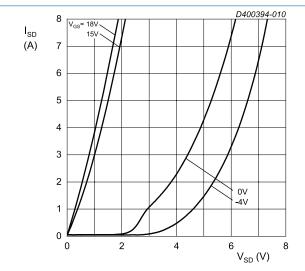
$$V_{DS} = 20 \text{ V; } t_p < 200 \text{ } \mu \text{s}$$
  
(1)  $T_j = 175 \text{ }^{\circ}\text{C}$   
(2)  $T_j = 25 \text{ }^{\circ}\text{C}$ 

(1) 
$$T_1 = 175 \,^{\circ}\text{C}$$

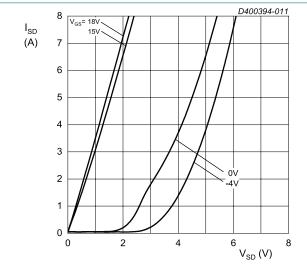
$$(2) T_i = 25 °C$$

$$(3) T_i = -55 ^{\circ}C$$

Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values

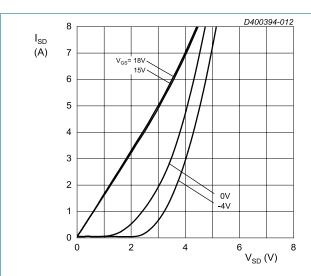


 $T_j = -55 \, ^{\circ}\text{C}; t_p < 200 \, \mu\text{s}$ Fig. 10. Body diode forward characteristics; typical values



 $T_{j} = 25 \, ^{\circ}\text{C}; t_{p} < 200 \, \mu\text{s}$ 

Fig. 11. Body diode forward characteristics; typical values



 $T_j = 175 \,^{\circ}\text{C}; t_p < 200 \,\mu\text{s}$ 

Fig. 12. Body diode forward characteristics; typical values

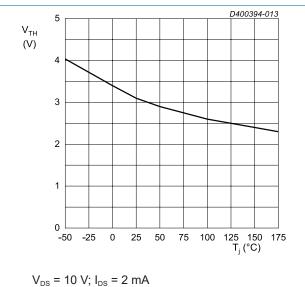
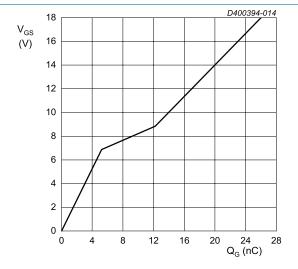


Fig. 13. Threshold voltage as a function of junction temperature



I<sub>DS</sub> = 2 A; I<sub>GS</sub> = 0.1 mA; V<sub>DS</sub> = 1200 V; T<sub>j</sub> = 25 °C Fig. 14. Gate-source voltage as a function of gate charge; typical values

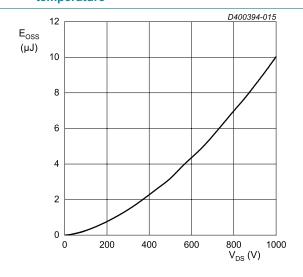
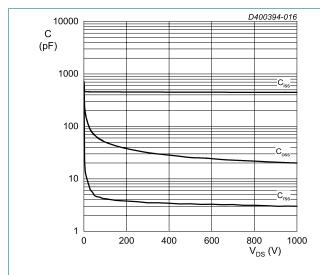
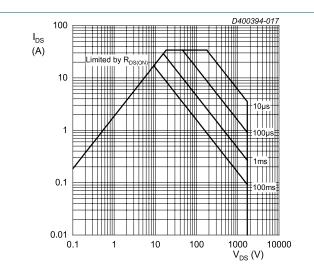


Fig. 15. Output capacitor stored energy as a function of drain-source voltage



 $V_{DS} = 0 - 1000 \text{ V}$ 

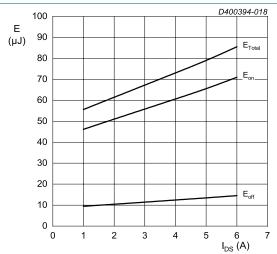
 $T_j = 25 \, ^{\circ}C; \, V_{AC} = 25 \, mV; \, f = 1 \, MHz$ 



 $T_j = 25 \,^{\circ}\text{C}; D = 0$ Parameter:  $t_p$ 

Fig. 17. Forward bias safe operating area

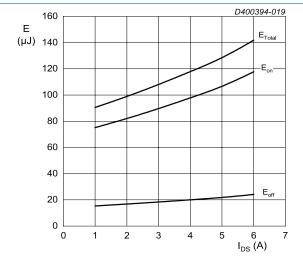




 $T_{j}$  = 25 °C;  $V_{DD}$  = 600 V;  $R_{G(ext)}$  = 2.4  $\Omega;$   $V_{GS}$  = 0 V/15 V; L = 330  $\mu H$ 

FWD = WNSC2M360170B7

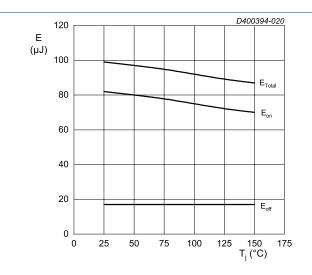
Fig. 18. Clamped Inductive Switching Energy as a function of drain current



 $T_{j}$  = 25 °C;  $V_{DD}$  = 800 V;  $R_{G(ext)}$  = 2.4  $\Omega;$   $V_{GS}$  = 0 V/15 V; L = 330  $\mu H$ 

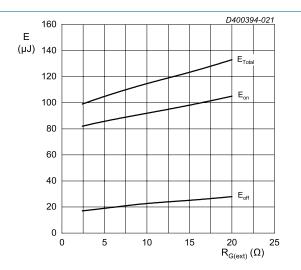
V<sub>GS</sub> = 0 V/15 V; L = 330 μH FWD = WNSC2M360170B7

Fig. 19. Clamped Inductive Switching Energy as a function of drain current



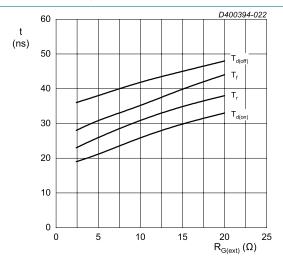
$$\begin{split} I_{DS} &= 2 \text{ A; V}_{DD} = 800 \text{ V; R}_{G(ext)} = 2.4 \text{ }\Omega; \\ V_{GS} &= 0 \text{ V/15 V; L} = 330 \text{ }\mu\text{H} \\ FWD &= WNSC2M360170B7 \end{split}$$

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



 $\rm T_{j}$  = 25 °C;  $\rm V_{DD}$  = 800 V;  $\rm I_{DS}$  = 2 A;  $\rm V_{GS}$  = 0 V/15 V FWD = WNSC2M360170B7; L = 330  $\rm \mu H$ 

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



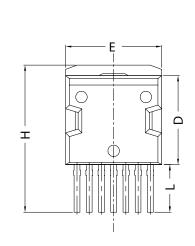
 $T_{j}=25~^{\circ}C;~V_{DD}=800~V;~I_{DS}=2~A;~V_{GS}=0~V/15~V$   $FWD=WNSC2M360170B7;~L=330~\mu H$  Fig. 22. Switching time as a function of external gate

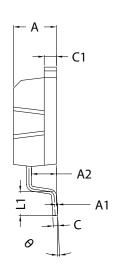
resistance

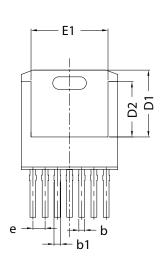
V<sub>DS</sub> 90% 90% 90% 90% 90% V<sub>GS</sub> t<sub>d(on)</sub> t<sub>d(off)</sub> t<sub>tOFF</sub>

Fig. 23. Switching time definition

# 11. Package outline

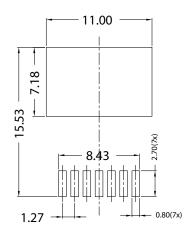






Dim	All Dime	nsions in Mill	imeters	
Diiii	Min	Тур	Max	
А	4.30	4.46	4.60	
A1	0	0.13	0.25	
A2	2.50	2.60	2.70	
b	0.50	0.60	0.70	
b1	0.50	0.70	0.90	
С	0.40	0.52	0.60	
C1	1.17	1.29	1.40	
D	9.00	9.25	9.50	
D1	6.80	6.95	7.10	
D2	5.60	5.75	5.90	
E	9.80	10.00	10.20	
E1	7.90	8.00	8.10	
e	1.27 BSC			
Н	14.60	15.30	16.00	
L	4.50	4.95	5.40	
L1	2.10	2.47	2.80	
θ	0°	4°	8°	

## Footprint:



## 12. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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### 13. Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Quick reference data	1
5. Pinning information	2
6. Ordering information	2
7. Marking	2
8. Limiting values	3
9. Thermal & Mechanical characteristics	4
10. Characteristics	5
11. Package outline	11
12. Legal information	12
13. Contents	14

For more information, please visit: http://www.ween-semi.com For sales office addresses, please send an email to: salesaddresses@ween-semi.com Date of release: 25 June 2025

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